

| Parameter | Symbol | Conditions | Values | | | Unit |
|---|------------|--|--------|------|------|------|
| | | | min. | typ. | max. | |
| Thermal characteristics¹⁾ | | | | | | |
| Thermal resistance, junction - case | R_{thJC} | | - | - | 2.6 | K/W |
| SMD version, device on PCB | R_{thJA} | minimal footprint | - | - | 62 | |
| | | 6 cm ² cooling area ³⁾ | - | - | 40 | |

Electrical characteristics, at $T_j=25^\circ\text{C}$, unless otherwise specified

Static characteristics

| | | | | | | |
|----------------------------------|---------------|---|-----|------|------|---------------|
| Drain-source breakdown voltage | $V_{(BR)DSS}$ | $V_{GS}=0V, I_D=1\text{mA}$ | 100 | - | - | V |
| Gate threshold voltage | $V_{GS(th)}$ | $V_{DS}=V_{GS}, I_D=29\mu\text{A}$ | 1.2 | 1.7 | 2.4 | |
| Zero gate voltage drain current | I_{DSS} | $V_{DS}=80V, V_{GS}=0V, T_j=25^\circ\text{C}$ | - | 0.01 | 0.1 | μA |
| | | $V_{DS}=80V, V_{GS}=0V, T_j=125^\circ\text{C}^{1)}$ | - | 1 | 10 | |
| Gate-source leakage current | I_{GSS} | $V_{GS}=16V, V_{DS}=0V$ | - | - | 100 | nA |
| Drain-source on-state resistance | $R_{DS(on)}$ | $V_{GS}=4.5V, I_D=30\text{A}$ | - | 32.2 | 41.8 | m Ω |
| | | $V_{GS}=10\text{V}, I_D=30\text{A}$ | - | 25.8 | 31.0 | |

| Parameter | Symbol | Conditions | Values | | | Unit |
|-----------|--------|------------|--------|------|------|------|
| | | | min. | typ. | max. | |

Dynamic characteristics¹⁾

| | | | | | | |
|------------------------------|--------------|---|---|------|------|----|
| Input capacitance | C_{iss} | $V_{GS}=0V, V_{DS}=25V,$ $f=1MHz$ | - | 1520 | 1976 | pF |
| Output capacitance | C_{oss} | | - | 380 | 494 | |
| Reverse transfer capacitance | C_{rss} | | - | 45 | 68 | |
| Turn-on delay time | $t_{d(on)}$ | $V_{DD}=20V, V_{GS}=10V,$ $I_D=30A, R_G=3.5\Omega$ | - | 6 | - | ns |
| Rise time | t_r | | - | 4 | - | |
| Turn-off delay time | $t_{d(off)}$ | | - | 18 | - | |
| Fall time | t_f | | - | 3 | - | |

Gate Charge Characteristics¹⁾

| | | | | | | |
|-----------------------|---------------|---|---|-----|----|----|
| Gate to source charge | Q_{gs} | $V_{DD}=80V, I_D=30A,$ $V_{GS}=0$ to 10V | - | 5 | 7 | nC |
| Gate to drain charge | Q_{gd} | | - | 4 | 6 | |
| Gate charge total | Q_g | | - | 24 | 31 | |
| Gate plateau voltage | $V_{plateau}$ | | - | 3.7 | - | V |

Reverse Diode

| | | | | | | |
|--|---------------|---|-----|-----|-----|----|
| Diode continuous forward current ¹⁾ | I_S | $T_C=25^\circ C$ | - | - | 30 | A |
| Diode pulse current ¹⁾ | $I_{S,pulse}$ | | - | - | 120 | |
| Diode forward voltage | V_{SD} | $V_{GS}=0V, I_F=30A,$ $T_j=25^\circ C$ | 0.6 | 1 | 1.2 | V |
| Reverse recovery time ¹⁾ | t_{rr} | $V_R=50V, I_F=I_S,$ $di_F/dt=100A/\mu s$ | - | 72 | - | ns |
| Reverse recovery charge ¹⁾ | Q_{rr} | | - | 150 | - | |

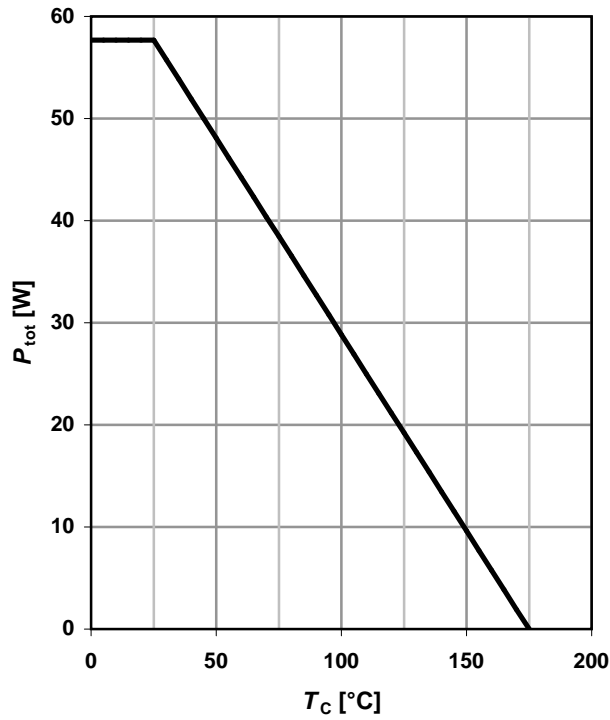
¹⁾ Defined by design. Not subject to production test.

²⁾ Qualified with $V_{GS} = +20/-5V$.

³⁾ Device on 40 mm x 40 mm x 1.5 mm epoxy PCB FR4 with 6 cm² (one layer, 70 μm thick) copper area for drain connection. PCB is vertical in still air.

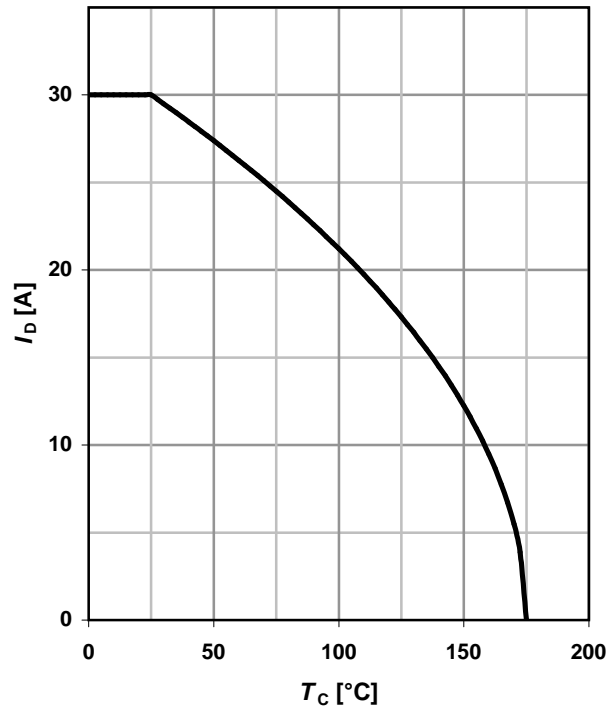
1 Power dissipation

$P_{tot} = f(T_C); V_{GS} \geq 6 V$



2 Drain current

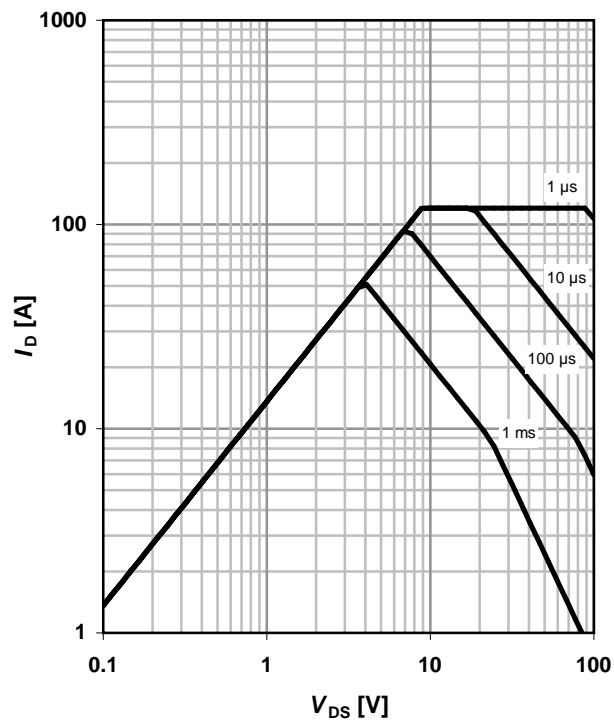
$I_D = f(T_C); V_{GS} \geq 6 V$



3 Safe operating area

$I_D = f(V_{DS}); T_C = 25\text{ °C}; D = 0$

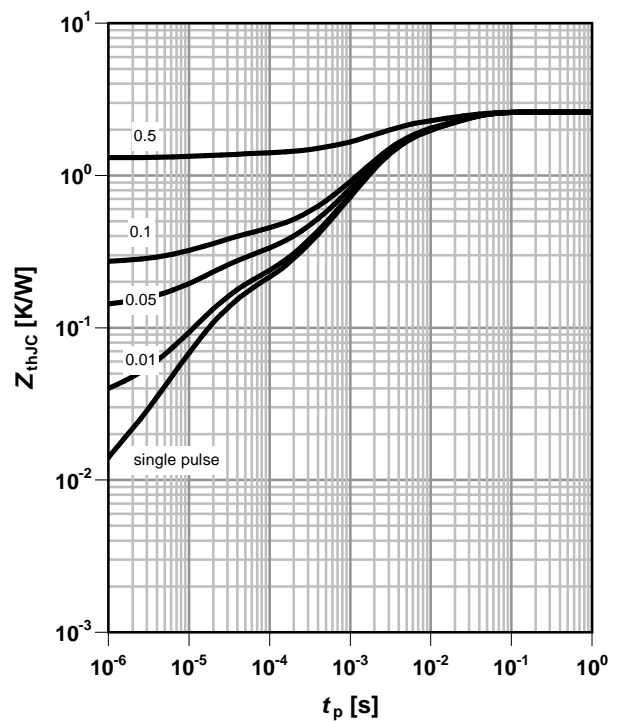
parameter: t_p



4 Max. transient thermal impedance

$Z_{thJC} = f(t_p)$

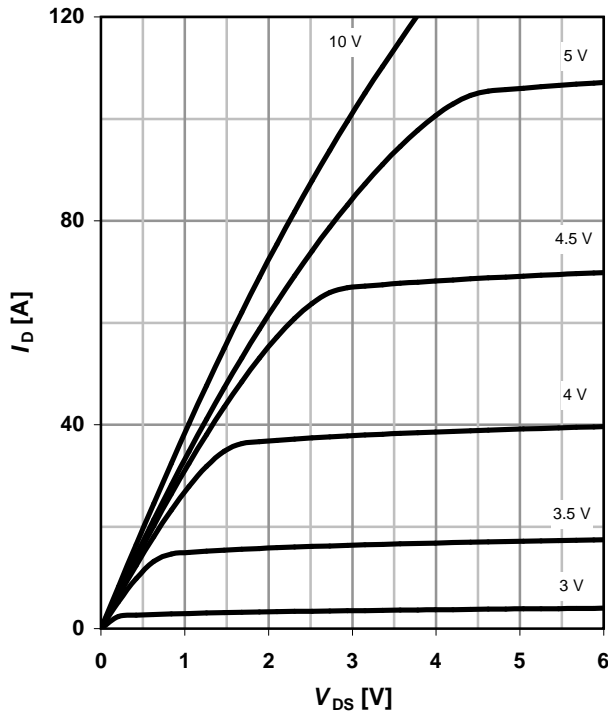
parameter: $D = t_p/T$



5 Typ. output characteristics

$I_D = f(V_{DS}); T_j = 25\text{ °C}$

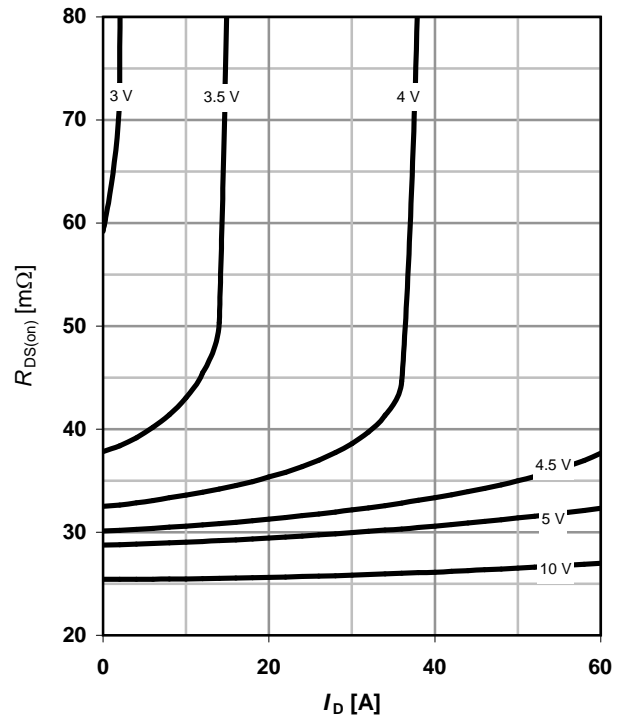
parameter: V_{GS}



6 Typ. drain-source on-state resistance

$R_{DS(on)} = f(I_D); T_j = 25\text{ °C}$

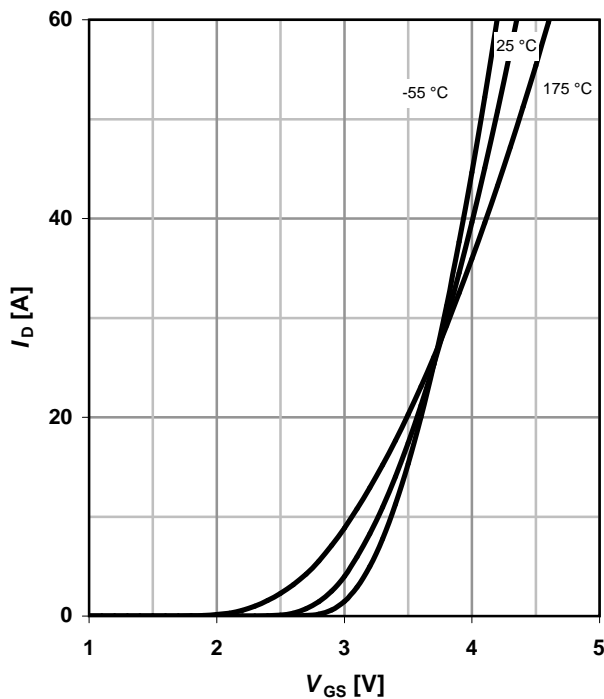
parameter: V_{GS}



7 Typ. transfer characteristics

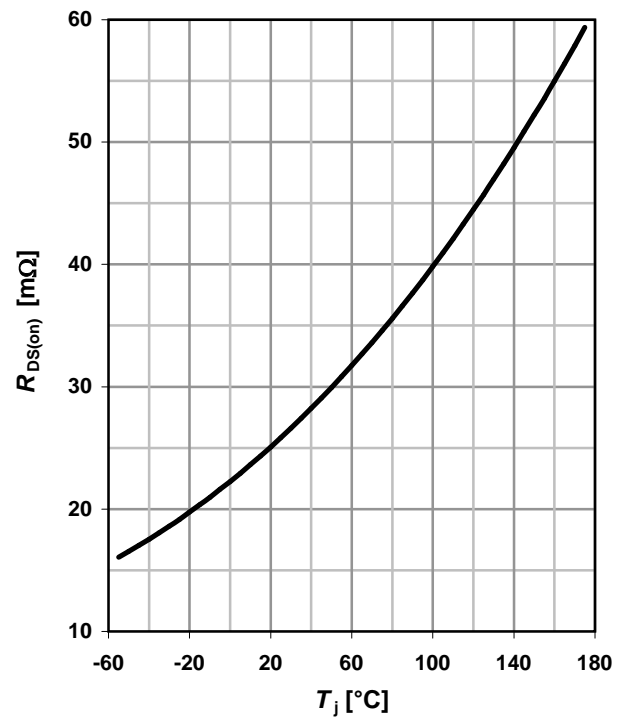
$I_D = f(V_{GS}); V_{DS} = 6V$

parameter: T_j



8 Typ. drain-source on-state resistance

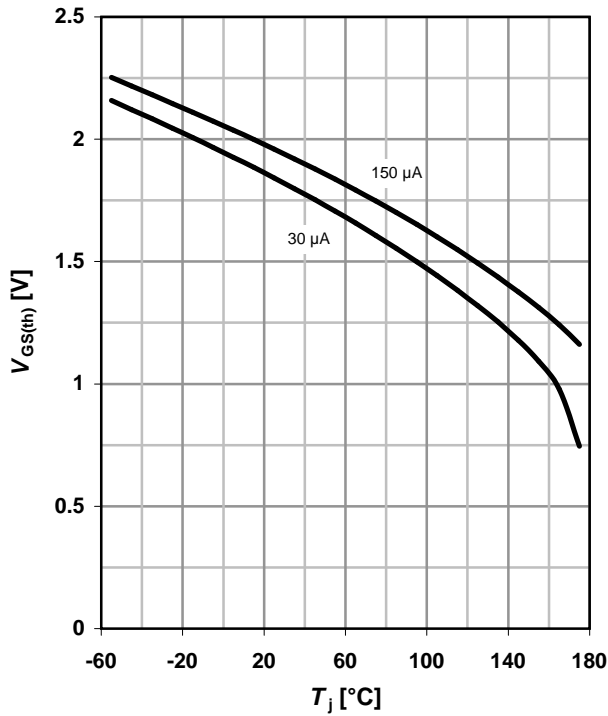
$R_{DS(on)} = f(T_j); I_D = 30\text{ A}; V_{GS} = 10\text{ V}$



9 Typ. gate threshold voltage

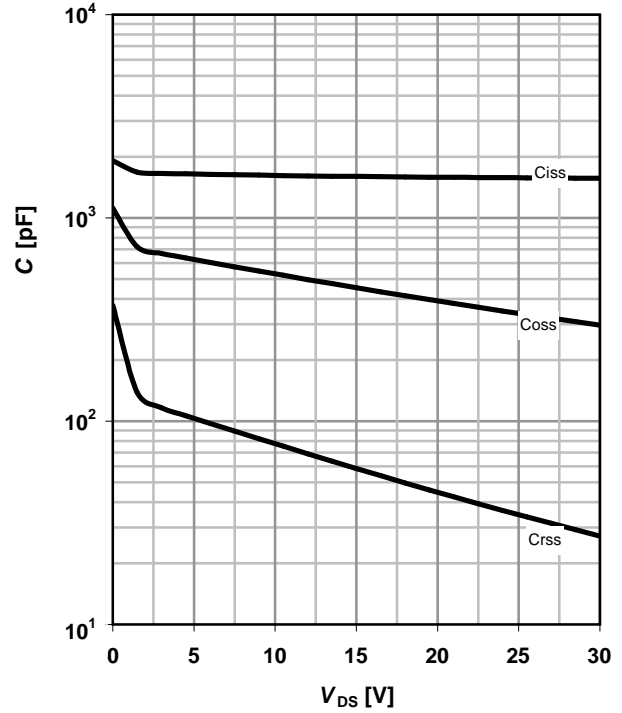
$V_{GS(th)} = f(T_j); V_{GS} = V_{DS}$

parameter: I_D



10 Typ. capacitances

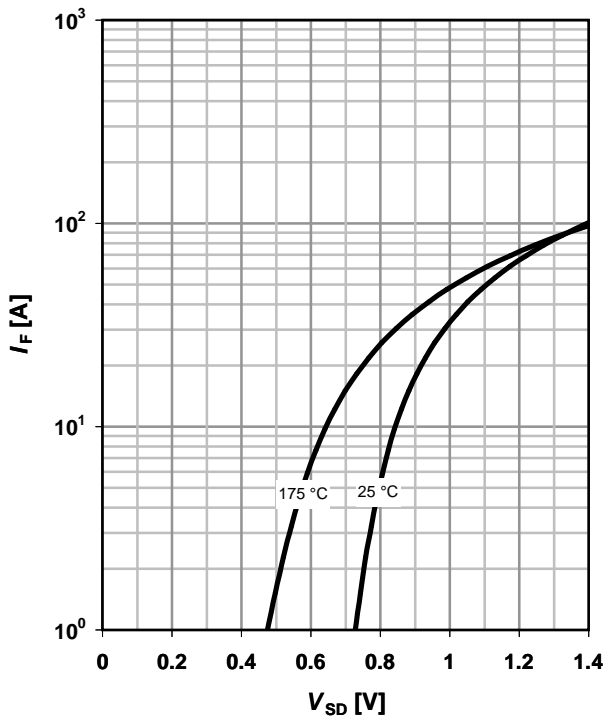
$C = f(V_{DS}); V_{GS} = 0 V; f = 1 MHz$



11 Typical forward diode characteristics

$I_F = f(V_{SD})$

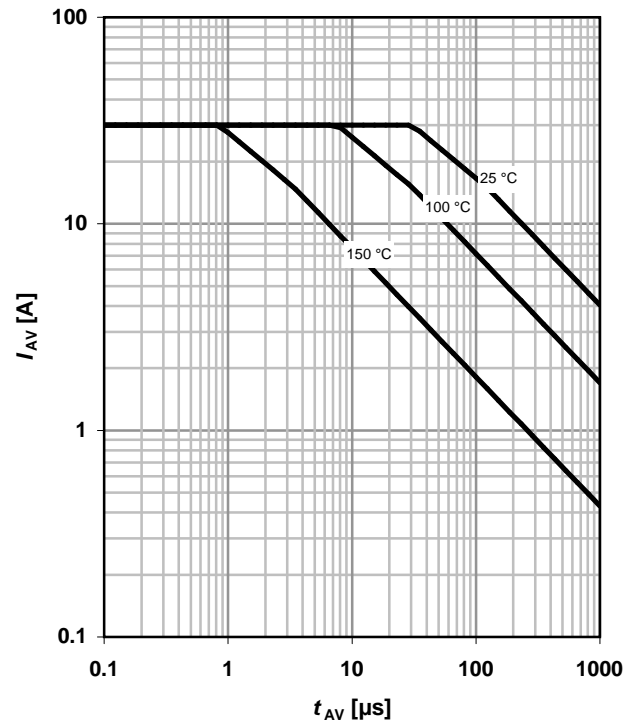
parameter: T_j



12 Typ. avalanche characteristics

$I_{AS} = f(t_{AV})$

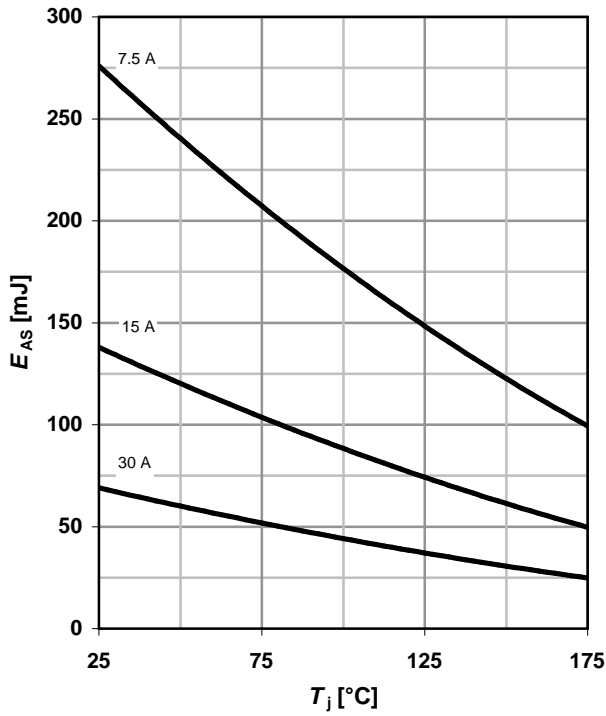
parameter: $T_{j(start)}$



13 Typical avalanche energy

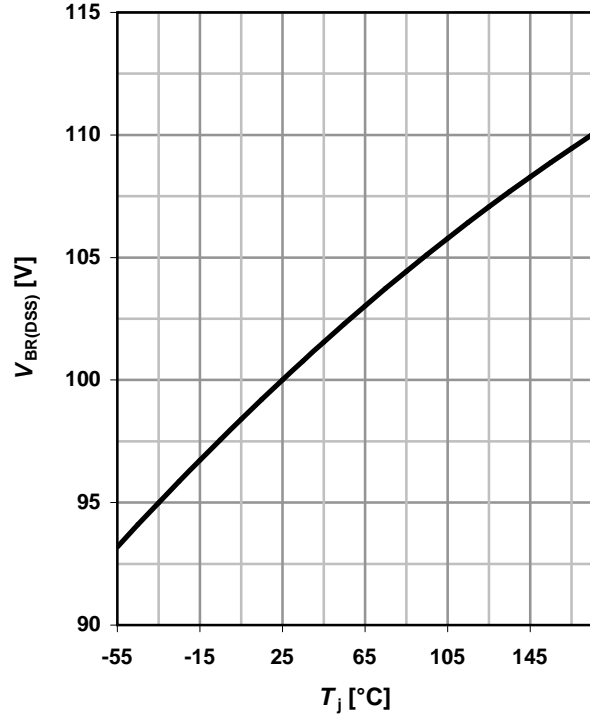
$$E_{AS} = f(T_j)$$

parameter: I_D



14 Typ. drain-source breakdown voltage

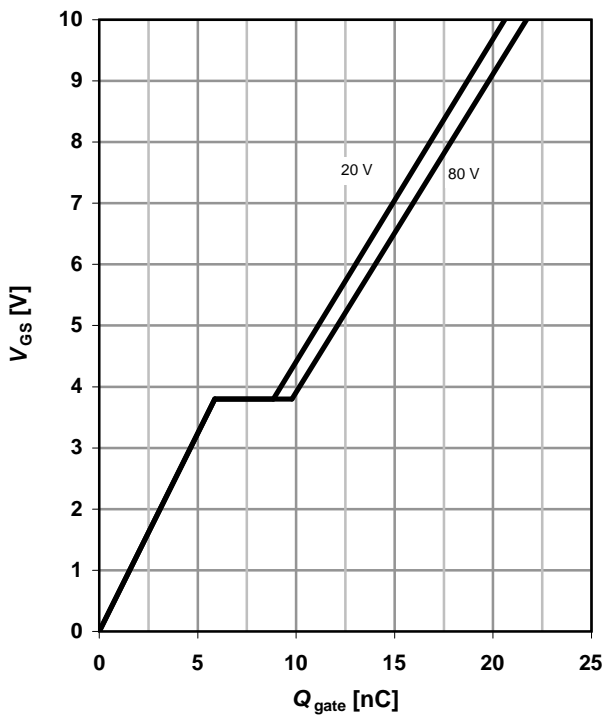
$$V_{BR(DSS)} = f(T_j); I_D = 1 \text{ mA}$$



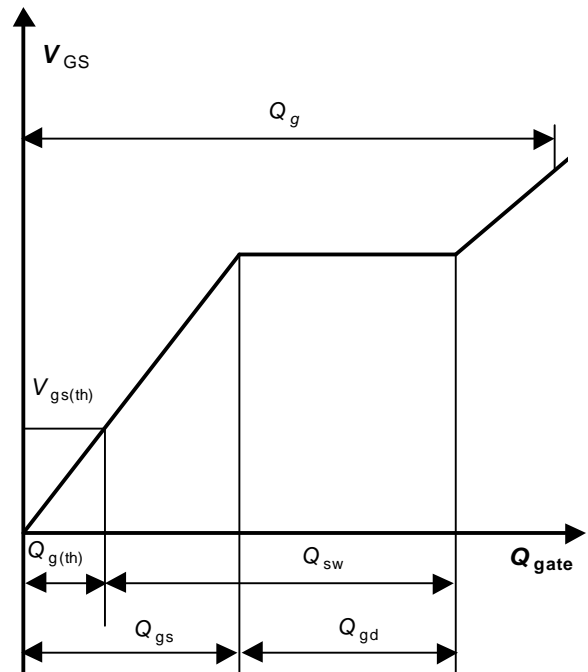
15 Typ. gate charge

$$V_{GS} = f(Q_{gate}); I_D = 30 \text{ A pulsed}$$

parameter: V_{DD}



16 Gate charge waveforms



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Revision History

| Version | Date | Changes |
|---------|------------|--|
| 1.1 | 08.04.2008 | Page 1: V_{GS} changed from $\pm 16V$ to $\pm 20V$ |
| 1.1 | 08.04.2008 | Page 3: Footnote 2) added |
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